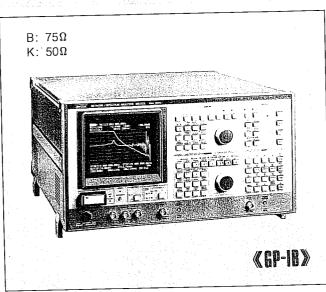
NEWORKANARATE

NETWORK/SPECTRUM ANALYZER MS420B/K 10 Hz to 30 MHz



The MS420B/K Network/Spectrum Analyzer is suitable for total evaluation of electronic devices, circuits, and elements. It can analyze magnitude, phase, delay time, levels and spectrum and frequencies of signals. The MS420B/K also has a built-in test-signal source and CRT display.

A high-performance synthesizer is used in the test-signal and local signal sources of the receiver, which gives very stable measurements and high resolution.

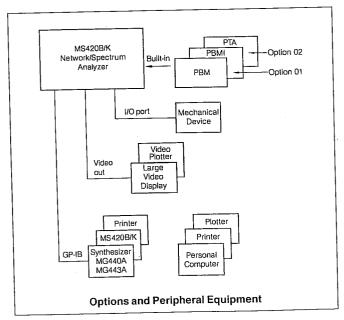
The following options are available for the MS420B/K

PTA (Personal Test Automation)

Controller used to construct a high-speed measuring system. Its programs are written in high-level language PTL (Personal Test Language) that is similar to BASIC.

PBMI (Plug-In Bubble Memory Interface)

8 kbyte PBM interface. A PBM can be plugged into the MS420B/K front panel and can memorize up to 6 functions or can file application programs written in PTL.



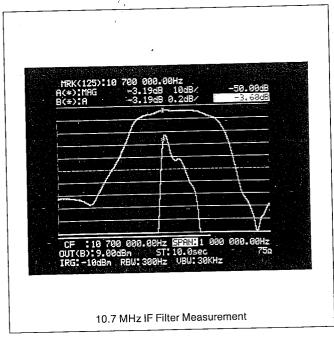
Features

- Wide measurable level range of over 150 dB, allowing the measured device to be checked at actual operational levels
- High-performance synthesizer to enable high resolution measurements
- High-speed measurement of 2 ms/point
 This is useful for speedier mass production of parts.
- High-precision group delay measurements
- Logarithmic frequency sweep
- Level sweep for non-linearity tests; variable input levels make the instrument suitable for characteristics tests
- Built-in GP-IB interface for remote control of front-panel functions
- Video output (rear panel) allows connection of a large-scale video display or video plotter (copy speed: about 13 s)
- Level calibration by using the output of the test-signal source
- External MG440A Synthesizer or MG443B SLG can be connected to check frequency response of conversion loss at different input/output frequencies

Applications

Filter adjustment

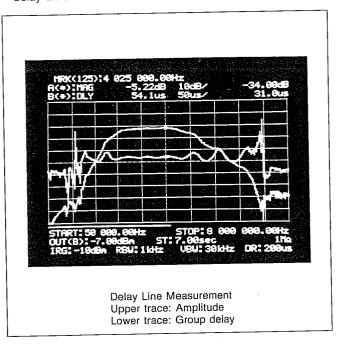
The MS420B/K can simultaneously display both the overall characteristics and passband ripple of a filter on the CRT. Therefore, passband ripple adjustment of a filter can be done while the overall frequency response is being observed.



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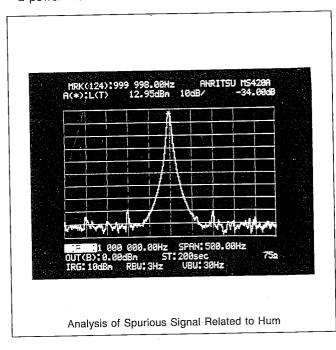
• High precision delay time measurement

Delay time and frequency response of VTR 1H delay lines must be measured precisely. The delay time expansion function of the MS420B/K can test samples that have very feeble frequency response in comparison with the absolute delay time. At 400 kHz aperture, samples of 1 μs delay time can be easily tested at a resolution of 1 ns. For VTR 1H delay lines, 63 μs delay time can be tested at 10 ns resolution.



High-resolution spectrum analysis

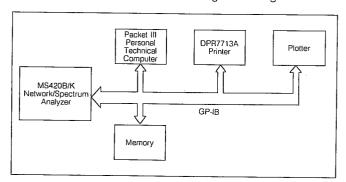
A high-performance synthesizer is built-in, so that stable analysis can be performed at a resolution bandwidth of 3 Hz. This permits accurate analysis of even a spurious signal from a power line.



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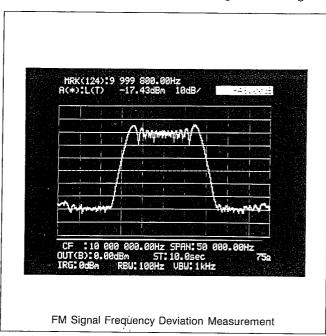
Connection to personal computer

The MS420B/K can be connected through the built-in GP-IB interface to a data processor, such as a personal computer, so that all the functions except the POWER switch and the INTENSITY control can be controlled externally. The interface is especially useful when a lot of data are to be processed, and when the MS420B/K is to be combined with other measuring instruments. An external memory, XY plotter, and serial printer can also be connected for recording and listing data.



Frequency shift measurement by MAX HOLD

The MAX HOLD function can measure frequency shift of FM signals and the degree of such shifts. The maximum value can be held easily for a spectrum with a large level change.



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| | Functions | Specifications | | | Network analysis | Spectrum analysis |
|----------------------------------------|------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------|---------------------|----------------------|
| | | Magnitude, Phase, Delay, Magnitude and Phase, Magnitude and Delay | | | • arranyola | 2.13/5/3 |
| Measuring items | | Level (R), Level (T), Spectrum (R), Spectrum (T) R: Reference input, T: Test input, Level: Measures the level only at frequency points displayed on the CRT, Spectrum: Displays the maximum value of the signal by making a measurement with frequency steps fine enough to acquire all frequencies in full sweep bandwidth. | | | | • |
| | Range | 10 Hz to 30 MHz. Resolution: 0.01 H | | | | • |
| Frequency | Reference crystal oscillator | Frequency: 10 MHz Stability: $\leq 5 \times 10^{-8}$ after 10-minute warm-up, based on the frequency after one hour warm-up $\pm 1 \times 10^{-7}$ (0° to 45°C) | | | | • |
| | Channel | 2 channels (R and T) | (0 10 10 0) | | | |
| Input | Impedance | 1 MΩ: 1 MΩ ±10% shunted by ≦70 pF (50 pF typical) 75 Ω: (MS420B); 50 Ω: (MS420K); Return loss: ≧30 dB | | | | |
| при | Range (IRG) | | | | - | |
| | Connector | - 40 to +20 dBm, 10 dB steps BNC | | | | • |
| | Image rejection | ≥70 dB | | | • | _ • |
| | IF rejection | ···· | | | • | • |
| | | ≥ 70 dB ≤ - 60 dB at 100 Hz to 200 kHz (Resolution bandwidth: ≤300 Hz) | | | | • |
| | Internal distortion | ≤ - 70 dB at 200 kHz to 15 M | • | • | | |
| | | At level measurement when the input channel and impedance are T and 75/50 Ω . | | | | |
| | | Resolution bandwidth | Frequency | Values relative to input range | | |
| Dynamic range | Average noise level | 10 Hz 10 Hz 30 Hz 30 Hz 100 Hz 300 Hz 1 kHz 3 kHz 10 kHz 30 kHz | 100 Hz to 30 MHz 10 kHz to 30 MHz 300 Hz to 30 MHz 10 kHz to 30 MHz 10 kHz to 30 MHz 3 kHz to 30 MHz 10 kHz to 30 MHz 30 kHz to 30 MHz 30 kHz to 30 MHz 300 kHz to 30 MHz | - 60 dB - 90 dB - 70 dB - 85 dB - 80 dB - 80 dB - 75 dB - 70 dB - 65 dB - 60 dB | | • |
| | Between input R | The best data for the network analysis is 10 dB or more improvement over above values. | | | | |
| Crosstalk | and T Between synthesizer | ≥ 100 dB | | | • | |
| | output and input T | ≥ 120 dB | | | | • |
| Resolution | 3 dB bandwidth | 3 Hz to 30 kHz in 1, 3 sequence | | | | |
| bandwidth | Selectivity | <20: 1, shape factor 60/3 dB | | | 7 • | • |
| Video bandwi | | 3 Hz to 30 kHz in 1, 3 sequence | | | • | • |
| Magnitude measure- ment | Range Offset error | 100 dB. Resolution: 0.01 dB Frequency response and input range/resolution bandwidth switching errors can automatically be corrected by memorizing the calibration data (usually based on the through connection). | | | | |
| | Linearity | 0 to -50 dB: ±0.15 dB -50 to -60 dB: ±0.5 dB -60 to -70 dB: ±1 dB -70 to -80 dB: ±2 dB ±1 dB (0 to -10 dB) for resolution bandwidth 3 Hz | | | | |
| Level/ spectrum measure- ment | Range | - 130 to +20 dBm. Resolution: 0.01 dB | | | | |
| | Offset error | Frequency response and input range errors can automatically be corrected by memorizing the standard data calibrated with the reference signal (synthesizer output) | | | | • |
| | Linearity | 0 to -50 dB: ±0.15 dB | | | | • |
| Phase measure- ment | Range | ±180° Resolution: 0.1° | | | | |
| | Offset error | Frequency response and input range/ resolution bandwidth switching errors can automatically be corrected by memorizing the calibration data (usually based on the through connection). | | | • | |
| | Level characteristic | 0 to -50 dB: ±1.5° -50 to | to -50 dB: ±1.5° -50 to -70 dB: ±3° at resolution bandwidth 3 kHz | | | |
| Delay measure- ment | Range | 1 μs to 400 ms in 1, 2, 4 sequence | | | | |
| | Resolution | Normal: 1/1000 of measurement range. Expand: 1/10000 of measurement range | | | | |
| | Offset error | Frequency response can be automatically corrected by memorizing the calibration data (usually based on the through connection). | | | • | |
| | Level characteristic | (0.5% of full scale +0.5% of real and resolution bandwidth ≥ 10 h | ading) at 0 to -50 dB Hz for µs range (1 to 30 N | ЛНz) | | |

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| | | 0.01 40 | | |
|-----------------------------------------|----------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---|---|
| Synthesizer output | A output | - 110 to +15 dBm, Resolution: 0.01 dB | | |
| | B output | -110 to +9 dBm, Resolution: 0.01 dB (power splitter output). Both outputs terminated. | | • |
| | Level accuracy | ±0.3 dB at +5 dBm | | |
| | Impedance | 75 Ω, Return loss: >30 dB (MS420B). 50 Ω, Return loss: >30 dB (MS420K) | _ | |
| | Connector | BNC | | • |
| Frequency measurement | | Resolution: 1 Hz. Accuracy: Reference frequency ±1 Hz | | + |
| Sweep | Frequency | LIN: START/STOP, CENTER/SPAN LOG: START/STOP START/STOP/STEP | | 6 |
| mode | Level | | | |
| Sweep points | | 251 | • | |
| Sweep time (ST) | | 500 ms* to 24 hours/SPAN *: Depends on measurement item and measurement conditions. | | • |
| Sweep | AUTO | Automatic sweep over the full range | | • |
| range | MARKER | Measures only marker point or sweeps only the range between two markers | | |
| Sweep contro | | | • | - |
| | | SIGNAL TRACK: Automatically ganged to maximum received signal | | • |
| Automatic setting | | BW, ST: COUPLED TO FREQ Resolution bandwidth, video bandwidth and sweep time are automatically set to the optimum values by ganging with span width | • | • |
| | | BW, ST: COUPLED TO SPAN Resolution bandwidth, video bandwidth and sweep time are automatically set to the optimum value by ganging with frequency | | • |
| Calibration | INT | Non-linearity error correction | | |
| | X→S | Offset error correction | | |
| | X—S | Automatic correction of offset error | | • |
| Calculation | A—B | Arithmetic processing between A and B memories Deviation between MAIN marker and \triangle marker | | |
| | Δ | | | |
| | ZERO | Deviation from reference value | | |
| | CRT | 6.5-inch electromagnetic deflection | | |
| | Trace | Same as the measuring items (rectangular coordinates) Same as the measuring items (rectangular coordinates) B, A, A—B. It is not performed for Magnitude/Phase and Magnitude/Delay 2 (MAIN marker and Δ marker) | | • |
| Display | Sub-trace | | | |
| | Markers | | | |
| | Character | Marker point data, trace condition, measurement condition | | |
| | Function memory | 3 (Trace condition, measurement condition) | | |
| Rear panel INPUT/ OUTPUT | Video output | 75 Ω load, approx. 1 V p-p (BNC) | | |
| | 10 MHz reference output | TTL level (BNC) TTL level (BNC) Open collector (36 pins) Compatible with IEEE-488 (24 pins) | | • |
| | 10 MHz reference input | | | |
| | X→S switching signal | | | |
| | GP-IB | | | |
| Remote control | | GP-IB (IEEE-488, IEC625-1, 24 pins) SH1, AH1, T6, L4, SR1, RL1, PP0, DC0, DT0, C28 All functions (except power and INTENSITY) of front panel are remotely controllable | | • |
| Power | | AC 100 V ±10%, 50/60 Hz, <330 VA | • | • |
| Ambient temperature, rated range of use | | 0° to +45°C | • | • |
| Dimensions | and weight | 221.5H × 426W × 451D mm, ≦35 kg | • | |

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